

TIDAS E UV/VIS - Entry Level Diode-Array Spectrometer for Education and Research



The TIDAS E series has been developed especially for education and research. This instrument range provides ease of use of the diode-array spectrometer and flexible optical fiber technology, at a reasonable price. The diode-array technology makes these instruments fast, precise and universally applicable.

The TIDAS E spectrometer series enables fast and efficient application of diode-array spectroscopy. They combine a detection system with an integrated light source, using the patented integrated dual cuvette holder and the option of the coupled external fiber-optic. External accessories such as sample or filter changers are energized through control wires and triggers. Through LAN connections, the TIDAS E is efficiently integrated into the existing network or connected directly to the computer.

The TIDAS E UV/VIS is suitable for the wavelength range from 190nm to 720nm and offers very high sensitivity. A deuterium/halogen light source is integrated.

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Member of THE PHARMA TEST GROUP



Specifications

Parameter	Specification
Order No.	81 699 14
Wavelength Range	UV/VIS 190 – 720 nm
Spectral Resolution	< 7 nm
Wavelength Accuracy	< 1 nm
Photometric Accuracy	± 10 mAU
Baseline Drift @ 250nm	1*10E-03 AU/h *1)
Signal-to-noise Ratio	< 4*10E-05 AU *2)
Included Light Source	Yes, fiberlight combination
Number of Diodes (Pixels)	256
Integrated Dual Cuvette holder	Yes, 10mm cuvette
Bench Space Requirements	approx. 26 x 15cm
Packaging Dimensions	approx. 46 x 32 x 30 cm (W x D x H)
Weight	approx. 5 kg net weight, 6 kg gross weight
Power Supply	85 – 265 VAC / 47 – 63 Hz
Interface	TCP/IP 10/100/1000 Mbit/s
Digital I/O	Standard: 2 x IN / 2 x OUT
A/D converter	16 Bit
Optical Fiber Connection	SMA 905
Supply Scope	TIDASDAQ software, Power supply, RJ 45 patch cable, user manual

We reserve the right to make technical changes without any prior notice.

*1) Baseline drift will be measured at 250 nm after 10h warm up @ 21°C±2°C ambient temperature according to ASTM E685

*2) Noise will be measured at 250 nm after 10h warm up @ 21°C±2°C ambient temperature according to ASTM E685, without methanol flow with the following settings:

- Integration time <100ms
- Pixel bunching 2 (2x2.2nm ~ 4nm)
- Integration time x accumulation <2 sec.
- Detector saturation ~ 80%,